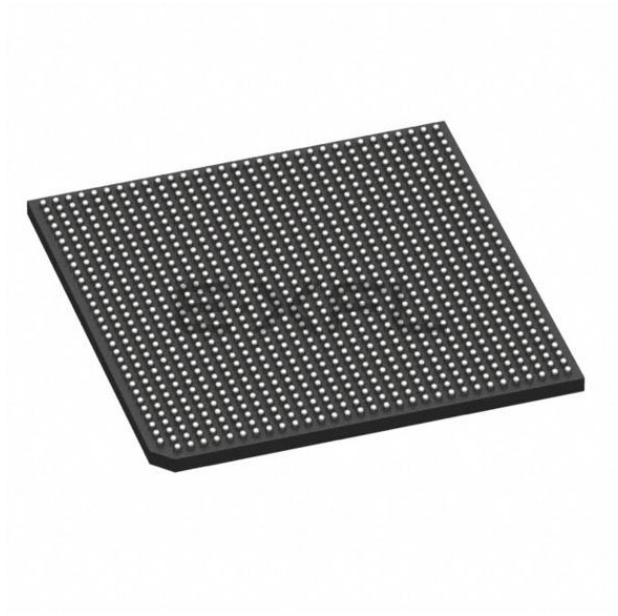

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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	2 Core, 32-Bit
Speed	1.2GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR2, DDR3
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.5V, 1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	1023-BFBGA, FCBGA
Supplier Device Package	1023-FCBGA (33x33)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8572evtatlb

Figure 6 provides the AC test load for the DDR2 and DDR3 Controller bus.

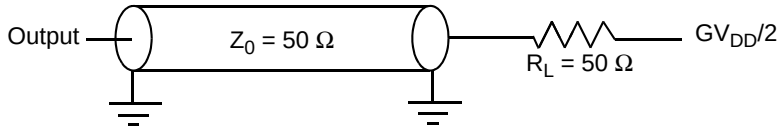
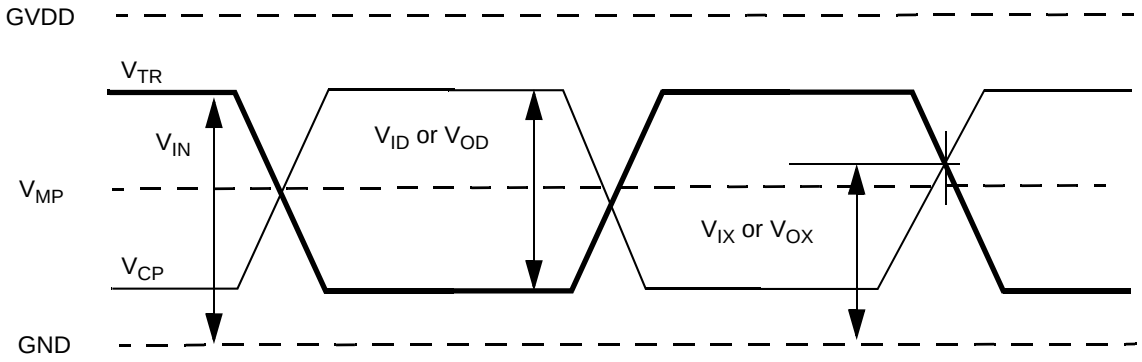


Figure 6. DDR2 and DDR3 Controller bus AC Test Load

6.2.3 DDR2 and DDR3 SDRAM Differential Timing Specifications

This section describes the DC and AC differential electrical specifications for the DDR2 and DDR3 SDRAM controller interface of the MPC8572E.



NOTE

VID specifies the input differential voltage |VTR -VCP| required for switching, where VTR is the true input signal (such as MCK or MDQS) and VCP is the complementary input signal (such as $\overline{\text{MCK}}$ or $\overline{\text{MDQS}}$).

Table 19 provides the differential specifications for the MPC8572E differential signals MDQS/$\overline{\text{MDQS}}$ and MCK/$\overline{\text{MCK}}$ when in DDR2 mode.

Table 19. DDR2 SDRAM Differential Electrical Characteristics

Parameter/Condition	Symbol	Min	Max	Unit	Notes
DC Input Signal Voltage	V_{IN}	–0.3	GV_{DD} + 0.3	V	—
DC Differential Input Voltage	V_{ID}	—	—	mV	—
AC Differential Input Voltage	V_{IDAC}	—	—	mV	—
DC Differential Output Voltage	V_{OH}	—	—	mV	—
AC Differential Output Voltage	V_{OHAC}	JEDEC: 0.5	JEDEC: GV_{DD} + 0.6	V	—
AC Differential Cross-point Voltage	V_{IXAC}	—	—	mV	—
Input Midpoint Voltage	V_{MP}	—	—	mV	—

8.3.3 SGMII Transmitter and Receiver DC Electrical Characteristics

Table 38 and Table 39 describe the SGMII SerDes transmitter and receiver AC-Coupled DC electrical characteristics. Transmitter DC characteristics are measured at the transmitter outputs (SD2_TX[n] and $\overline{\text{SD2\_TX[n]}}$) as depicted in Figure 23.

Table 38. SGMII DC Transmitter Electrical Characteristics

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Supply Voltage	XV_{DD_SRDS2}	1.045	1.1	1.155	V	—
Output high voltage	VOH	—	—	$XV_{DD\_SRDS2-Typ}/2 + \lvert\overline{V_{OD}}\rvert_{-max}/2$	mV	1
Output low voltage	VOL	$XV_{DD\_SRDS2-Typ}/2 - \lvert V_{OD}\rvert_{-max}/2$	—	—	mV	1
Output ringing	V_{RING}	—	—	10	%	—
Output differential voltage[2, 3, 5]	$\lvert V_{OD}\rvert$	359	550	791	mV	Equalization setting: 1.0x
		329	505	725		Equalization setting: 1.09x
		299	458	659		Equalization setting: 1.2x
		270	414	594		Equalization setting: 1.33x
		239	367	527		Equalization setting: 1.5x
		210	322	462		Equalization setting: 1.71x
		180	275	395		Equalization setting: 2.0x
Output offset voltage	V_{OS}	473	550	628	mV	1, 4
Output impedance (single-ended)	R_O	40	—	60	Ω	—
Mismatch in a pair	ΔR_O	—	—	10	%	—
Change in V_{OD} between “0” and “1”	$\Delta \lvert V_{OD}\rvert$	—	—	25	mV	—

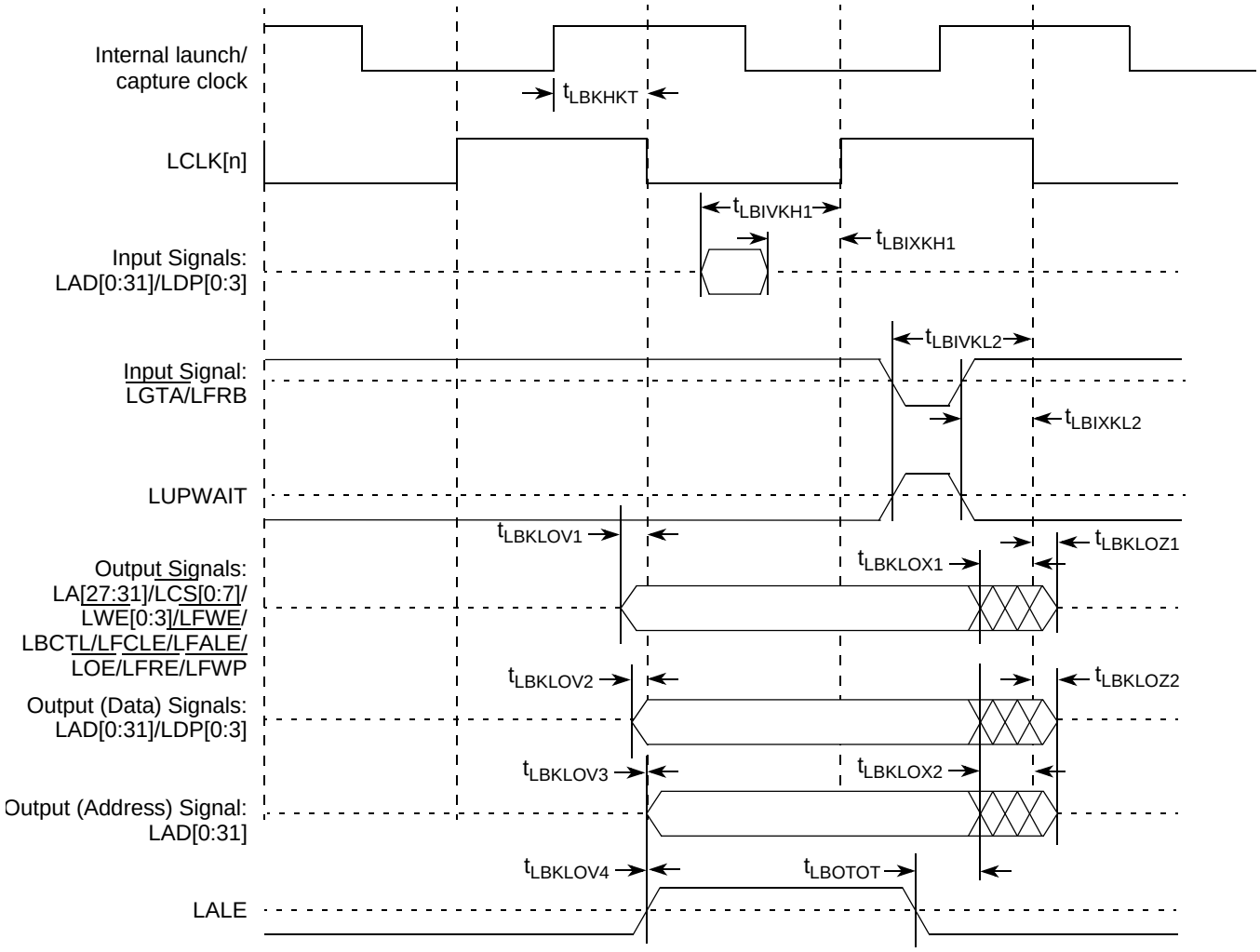


Figure 31. Local Bus Signals (PLL Bypass Mode)

Table 54. I²C DC Electrical Characteristics (continued)

Capacitance for each I/O pin	C_I	—	10	pF	—

Notes:
1. Output voltage (open drain or open collector) condition = 3 mA sink current.
2. Refer to the *MPC8572E PowerQUICC™ III Integrated Host Processor Family Reference Manual* for information on the digital filter used.
3. I/O pins will obstruct the SDA and SCL lines if OV_{DD} is switched off.

13.2 I²C AC Electrical Specifications

Table 55 provides the AC timing parameters for the I²C interfaces.

Table 55. I²C AC Electrical Specifications

At recommended operating conditions with OV_{DD} of 3.3 V ± 5%. All values refer to V_{IH} (min) and V_{IL} (max) levels (see Table 2).

Parameter	Symbol[1]	Min	Max	Unit
SCL clock frequency	f_{I2C}	0	400	kHz[4]
Low period of the SCL clock	t_{I2CL}	1.3	—	µs
High period of the SCL clock	t_{I2CH}	0.6	—	µs
Setup time for a repeated START condition	t_{I2SVKH}	0.6	—	µs
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t_{I2SXKL}	0.6	—	µs
Data setup time	t_{I2DVKH}	100	—	ns
Data input hold time: CBUS compatible masters I²C bus devices	t_{I2DXKL}	 — 0[2]	 — —	µs
Data output delay time	t_{I2OVKL}	—	0.9[3]	µs
Setup time for STOP condition	t_{I2PVKH}	0.6	—	µs
Bus free time between a STOP and START condition	t_{I2KHDX}	1.3	—	µs
Noise margin at the LOW level for each connected device (including hysteresis)	V_{NL}	$0.1 \times OV_{DD}$	—	V
Noise margin at the HIGH level for each connected device (including hysteresis)	V_{NH}	$0.2 \times OV_{DD}$	—	V

clock driver chip manufacturer to verify whether this connection scheme is compatible with a particular clock driver chip.

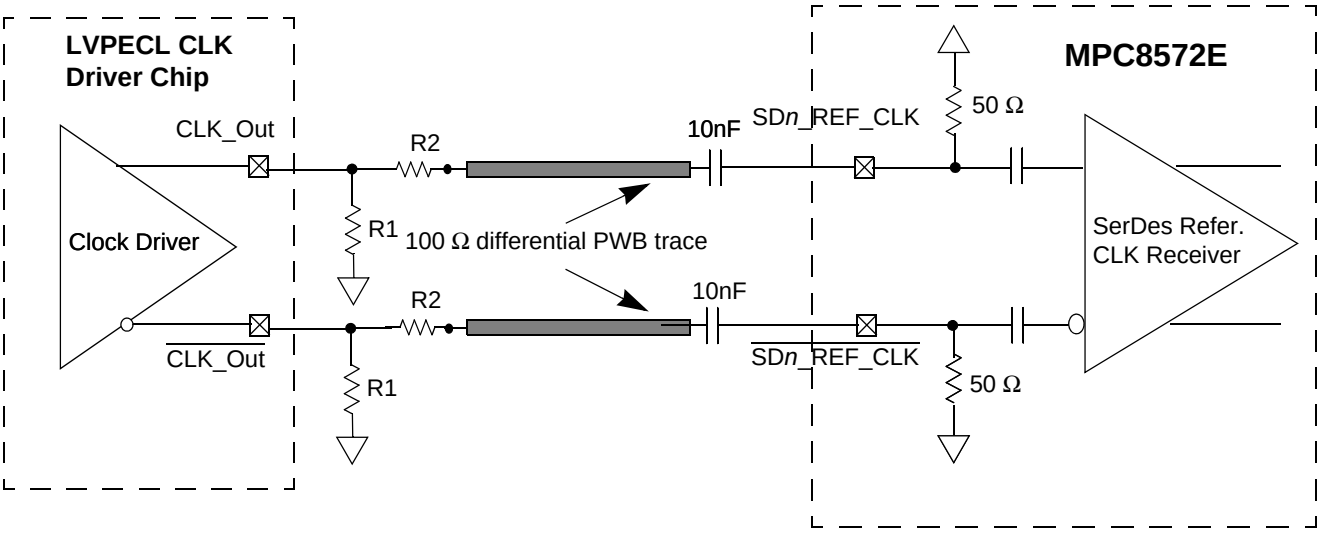


Figure 50. AC-Coupled Differential Connection with LVPECL Clock Driver (Reference Only)

Figure 51 shows the SerDes reference clock connection reference circuits for a single-ended clock driver. It assumes the DC levels of the clock driver are compatible with MPC8572E SerDes reference clock input's DC requirement.

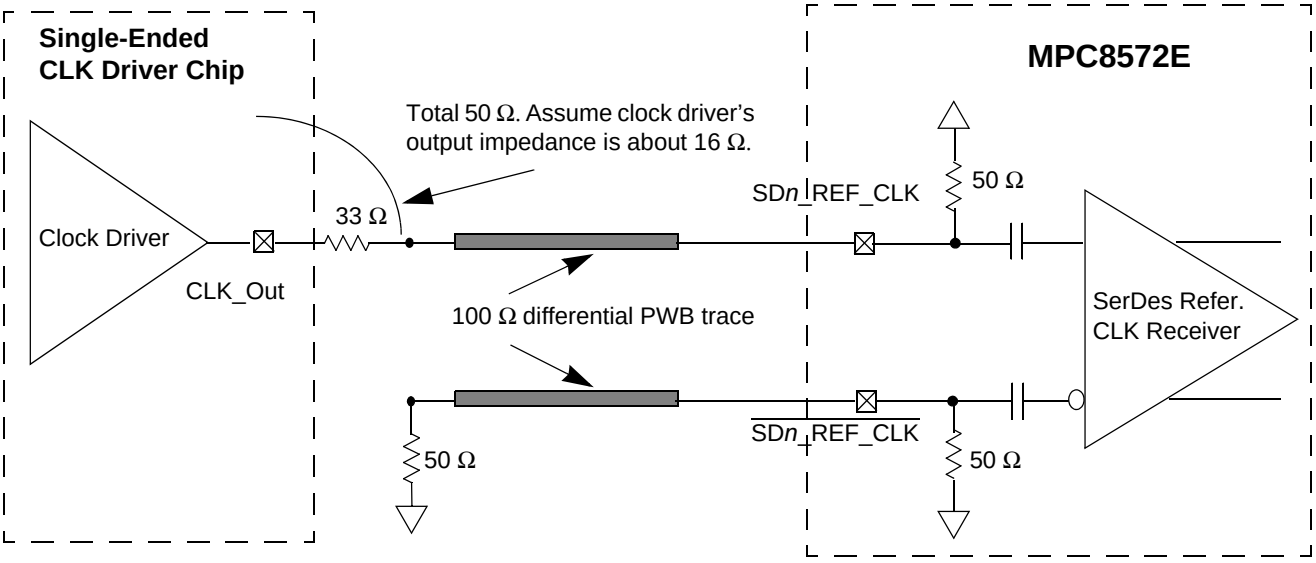


Figure 51. Single-Ended Connection (Reference Only)

15.2.4 AC Requirements for SerDes Reference Clocks

The clock driver selected should provide a high quality reference clock with low phase noise and cycle-to-cycle jitter. Phase noise less than 100KHz can be tracked by the PLL and data recovery loops and

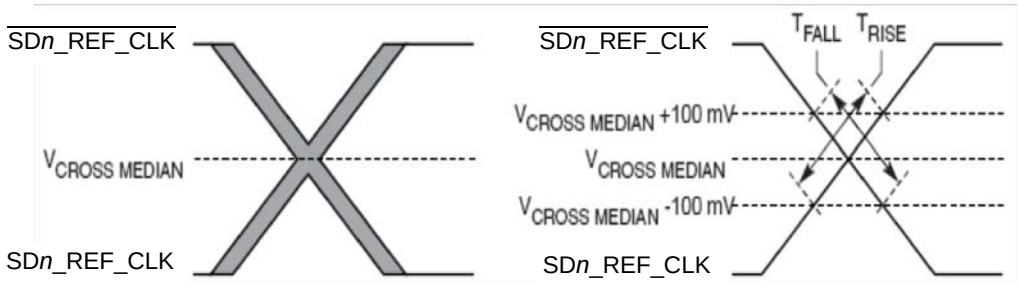


Figure 53. Single-Ended Measurement Points for Rise and Fall Time Matching

The other detailed AC requirements of the SerDes Reference Clocks is defined by each interface protocol based on application usage. Refer to the following sections for detailed information:

- Section 8.3.2, "AC Requirements for SGMII SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$"
- Section 16.2, "AC Requirements for PCI Express SerDes Reference Clocks"
- Section 17.2, "AC Requirements for Serial RapidIO SD1_REF_CLK and $\overline{\text{SD1\_REF\_CLK}}$"

15.2.4.1 Spread Spectrum Clock

SD1_REF_CLK/$\overline{\text{SD1\_REF\_CLK}}$ are designed to work with a spread spectrum clock (+0 to –0.5% spreading at 30–33 KHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation should be used.

SD2_REF_CLK/$\overline{\text{SD2\_REF\_CLK}}$ are not to be used with, and should not be clocked by, a spread spectrum clock source.

15.3 SerDes Transmitter and Receiver Reference Circuits

Figure 54 shows the reference circuits for SerDes data lane's transmitter and receiver.

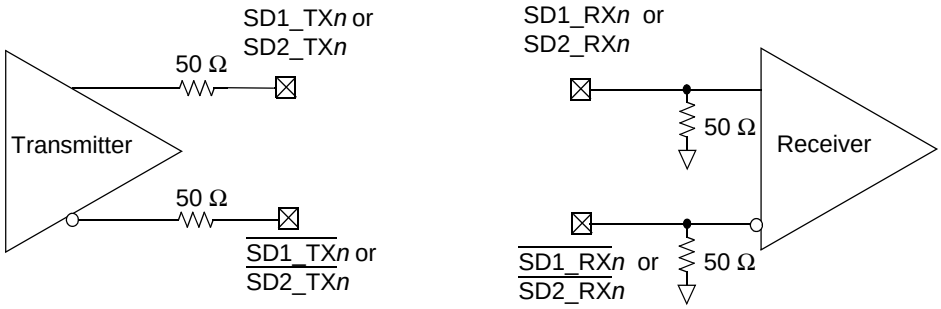


Figure 54. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below (PCI Express, Serial Rapid IO or SGMII) in this document based on the application usage:

- Section 8.3, "SGMII Interface Electrical Characteristics"
- Section 16, "PCI Express"

- Section 17, “Serial RapidIO”

Note that external AC Coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in specification of each protocol section.

16 PCI Express

This section describes the DC and AC electrical specifications for the PCI Express bus of the MPC8572E.

16.1 DC Requirements for PCI Express SD1_REF_CLK and SD1_REF_CLK

For more information, see Section 15.2, “SerDes Reference Clocks.”

16.2 AC Requirements for PCI Express SerDes Reference Clocks

Table 61 lists AC requirements.

Table 61. SD1_REF_CLK and $\overline{\text{SD1\_REF\_CLK}}$ AC Requirements

Symbol	Parameter Description	Min	Typical	Max	Units	Notes
t_{REF}	REFCLK cycle time	—	10	—	ns	1
t_{REFCJ}	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles	—	—	100	ps	—
t_{REFPJ}	Phase jitter. Deviation in edge location with respect to mean edge location	–50	—	50	ps	—

Notes:
1. Typical cycle time is based on PCI Express Card Electromechanical Specification Revision 1.0a.

16.3 Clocking Dependencies

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a +/– 300 ppm tolerance.

16.4 Physical Layer Specifications

The following is a summary of the specifications for the physical layer of PCI Express on this device. For further details as well as the specifications of the transport and data link layer, Use the PCI Express Base Specification. REV. 1.0a document.

16.4.1 Differential Transmitter (TX) Output

Table 62 defines the specifications for the differential output at all transmitters (TXs). The parameters are specified at the component pins.

Table 63. Differential Receiver (RX) Input Specifications (continued)

Symbol	Parameter	Min	Nominal	Max	Units	Comments
$L_{RX-SKEW}$	Total Skew	—	—	20	ns	Skew across all lanes on a Link. This includes variation in the length of SKP ordered set (for example, COM and one to five SKP Symbols) at the RX as well as any delay differences arising from the interconnect itself.

Notes:
1. No test load is necessarily associated with this value.
2. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in Figure 57 should be used as the RX device when taking measurements (also refer to the Receiver compliance eye diagram shown in Figure 56). If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
3. A T_{RX-EYE} = 0.40 UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the Transmitter and interconnect collected any 250 consecutive UIs. The $T_{RX-EYE-MEDIAN-to-MAX-JITTER}$ specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive TX UIs. It should be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
4. The Receiver input impedance shall result in a differential return loss greater than or equal to 15 dB with the D+ line biased to 300 mV and the D- line biased to -300 mV and a common mode return loss greater than or equal to 6 dB (no bias required) over a frequency range of 50 MHz to 1.25 GHz. This input impedance requirement applies to all valid input levels. The reference impedance for return loss measurements for is 50 ohms to ground for both the D+ and D- line (that is, as measured by a Vector Network Analyzer with 50 ohm probes - see Figure 57). Note: that the series capacitors CTX is optional for the return loss measurement.
5. Impedance during all LTSSM states. When transitioning from a Fundamental Reset to Detect (the initial state of the LTSSM) there is a 5 ms transition time before Receiver termination values must be met on all un-configured Lanes of a Port.
6. The RX DC Common Mode Impedance that exists when no power is present or Fundamental Reset is asserted. This helps ensure that the Receiver Detect circuit does not falsely assume a Receiver is powered on when it is not. This term must be measured at 300 mV above the RX ground.
7. It is recommended that the recovered TX UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.

16.5.1 Compliance Test and Measurement Load

The AC timing and voltage parameters must be verified at the measurement point, as specified within 0.2 inches of the package pins, into a test/measurement load shown in Figure 57.

NOTE

The allowance of the measurement point to be within 0.2 inches of the package pins is meant to acknowledge that package/board routing may benefit from D+ and D– not being exactly matched in length at the package pin boundary.

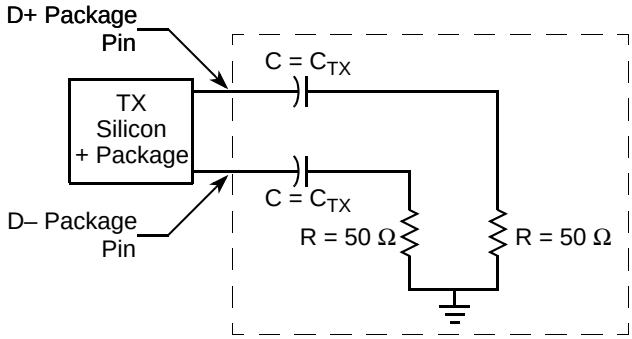


Figure 57. Compliance Test/Measurement Load

17 Serial RapidIO

This section describes the DC and AC electrical specifications for the RapidIO interface of the MPC8572E for the LP-Serial physical layer. The electrical specifications cover both single and multiple-lane links. Two transmitters (short run and long run) and a single receiver are specified for each of three baud rates, 1.25, 2.50, and 3.125 GBaud.

Two transmitter specifications allow for solutions ranging from simple board-to-board interconnect to driving two connectors across a backplane. A single receiver specification is given that accepts signals from both the short run and long run transmitter specifications.

The short run transmitter should be used mainly for chip-to-chip connections on either the same printed circuit board or across a single connector. This covers the case where connections are made to a mezzanine (daughter) card. The minimum swings of the short run specification reduce the overall power used by the transceivers.

The long run transmitter specifications use larger voltage swings that are capable of driving signals across backplanes. This allows a user to drive signals across two connectors and a backplane. The specifications allow a distance of at least 50 cm at all baud rates.

All unit intervals are specified with a tolerance of +/– 100 ppm. The worst case frequency difference between any transmit and receive clock is 200 ppm.

To ensure interoperability between drivers and receivers of different vendors and technologies, AC coupling at the receiver input must be used.

17.1 DC Requirements for Serial RapidIO SD1_REF_CLK and SD1_REF_CLK

For more information, see Section 15.2, “SerDes Reference Clocks.”

17.2 AC Requirements for Serial RapidIO SD1_REF_CLK and SD1_REF_CLK

Figure 64lists the AC requirements.

Table 64. SD*n*_REF_CLK and $\overline{\text{SD}n\text{\_REF\_CLK}}$ AC Requirements

Symbol	Parameter Description	Min	Typical	Max	Units	Comments
t_{REF}	REFCLK cycle time	—	10(8)	—	ns	8 ns applies only to serial RapidIO with 125-MHz reference clock
t_{REFCJ}	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles	—	—	80	ps	—
t_{REFPJ}	Phase jitter. Deviation in edge location with respect to mean edge location	–40	—	40	ps	—

17.3 Equalization

With the use of high speed serial links, the interconnect media causes degradation of the signal at the receiver. Effects such as Inter-Symbol Interference (ISI) or data dependent jitter are produced. This loss can be large enough to degrade the eye opening at the receiver beyond what is allowed in the specification. To negate a portion of these effects, equalization can be used. The most common equalization techniques that can be used are as follows:

- A passive high pass filter network placed at the receiver. This is often referred to as passive equalization.
- The use of active circuits in the receiver. This is often referred to as adaptive equalization.

17.4 Explanatory Note on Transmitter and Receiver Specifications

AC electrical specifications are given for transmitter and receiver. Long run and short run interfaces at three baud rates (a total of six cases) are described.

The parameters for the AC electrical specifications are guided by the XAUI electrical interface specified in Clause 47 of IEEE 802.3ae-2002.

XAUI has similar application goals to serial RapidIO, as described in Section 8.1, “Enhanced Three-Speed Ethernet Controller (eTSEC) (10/100/1000 Mbps)—FIFO/GMII/MII/TBI/RGMII/RTBI/RMII Electrical Characteristics.” The goal of this standard is that electrical designs for Serial RapidIO can reuse electrical designs for XAUI, suitably modified for applications at the baud intervals and reaches described herein.

Table 72. Receiver AC Timing Specifications—1.25 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential Input Voltage	V_{IN}	200	1600	mV p-p	Measured at receiver
Deterministic Jitter Tolerance	J_D	0.37	—	UI p-p	Measured at receiver
Combined Deterministic and Random Jitter Tolerance	J_{DR}	0.55	—	UI p-p	Measured at receiver
Total Jitter Tolerance[1]	J_T	0.65	—	UI p-p	Measured at receiver
Multiple Input Skew	S_{MI}	—	24	ns	Skew at the receiver input between lanes of a multilane link
Bit Error Rate	BER	—	10^{-12}	—	—
Unit Interval	UI	800	800	ps	+/– 100 ppm

Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 59. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

Table 73. Receiver AC Timing Specifications—2.5 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential Input Voltage	V_{IN}	200	1600	mV p-p	Measured at receiver
Deterministic Jitter Tolerance	J_D	0.37	—	UI p-p	Measured at receiver
Combined Deterministic and Random Jitter Tolerance	J_{DR}	0.55	—	UI p-p	Measured at receiver
Total Jitter Tolerance[1]	J_T	0.65	—	UI p-p	Measured at receiver
Multiple Input Skew	S_{MI}	—	24	ns	Skew at the receiver input between lanes of a multilane link
Bit Error Rate	BER	—	10^{-12}	—	—
Unit Interval	UI	400	400	ps	+/– 100 ppm

Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 59. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

Table 74. Receiver AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential Input Voltage	V_{IN}	200	1600	mV p-p	Measured at receiver
Deterministic Jitter Tolerance	J_D	0.37	—	UI p-p	Measured at receiver
Combined Deterministic and Random Jitter Tolerance	J_{DR}	0.55	—	UI p-p	Measured at receiver
Total Jitter Tolerance[1]	J_T	0.65	—	UI p-p	Measured at receiver
Multiple Input Skew	S_{MI}	—	22	ns	Skew at the receiver input between lanes of a multilane link
Bit Error Rate	BER	—	10^{-12}	—	—
Unit Interval	UI	320	320	ps	+/- 100 ppm

Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 59. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

Table 76. MPC8572E Pinout Listing (continued)

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
TSEC3_GTX_CLK	Transmit Clock Out	AE17	O	TV_{DD}	
TSEC3_RX_CLK/FEC_RX_CLK/FIFO3_RX_CLK	Receive Clock	AF17	I	TV_{DD}	1
TSEC3_RX_DV/FEC_RX_DV/FIFO3_RX_DV	Receive Data Valid	AG14	I	TV_{DD}	1
TSEC3_RX_ER/FEC_RX_ER/FIFO3_RX_ER	Receive Error	AH15	I	TV_{DD}	1
TSEC3_TX_CLK/FEC_TX_CLK/FIFO3_TX_CLK	Transmit Clock In	AF16	I	TV_{DD}	1
TSEC3_TX_EN/FEC_TX_EN/FIFO3_TX_EN	Transmit Enable	AJ18	O	TV_{DD}	1, 22
Three-Speed Ethernet Controller 4					
TSEC4_TXD[3:0]/TSEC3_TXD[7:4]/FIFO3_TXD[7:4]	Transmit Data	AD15, AC16, AC14, AB16	O	TV_{DD}	1, 5, 9
TSEC4_RXD[3:0]/TSEC3_RXD[7:4]/FIFO3_RXD[7:4]	Receive Data	AE15, AF13, AE14, AH14	I	TV_{DD}	1
TSEC4_GTX_CLK	Transmit Clock Out	AB14	O	TV_{DD}	—
TSEC4_RX_CLK/TSEC3_COL/FEC_COL/FIFO3_TX_FC	Receive Clock	AG13	I	TV_{DD}	1
TSEC4_RX_DV/TSEC3_CRS/FEC_CRS/FIFO3_RX_FC	Receive Data Valid	AD13	I/O	TV_{DD}	1, 23
TSEC4_TX_EN/TSEC3_TX_ER/FEC_TX_ER/FIFO3_TX_ER	Transmit Enable	AB15	O	TV_{DD}	1, 22
DUART					
$\overline{\text{UART\_CTS}}$[0:1]	Clear to Send	W30, Y27	I	OV_{DD}	—
$\overline{\text{UART\_RTS}}$[0:1]	Ready to Send	W31, Y30	O	OV_{DD}	5, 9
UART_SIN[0:1]	Receive Data	Y26, W29	I	OV_{DD}	—
UART_SOUT[0:1]	Transmit Data	Y25, W26	O	OV_{DD}	5, 9
I^2C Interface					
IIC1_SCL	Serial Clock	AC30	I/O	OV_{DD}	4, 20
IIC1_SDA	Serial Data	AB30	I/O	OV_{DD}	4, 20
IIC2_SCL	Serial Clock	AD30	I/O	OV_{DD}	4, 20
IIC2_SDA	Serial Data	AD29	I/O	OV_{DD}	4, 20
SerDes (x10) PCIe, SRIO					

Table 76. MPC8572E Pinout Listing (continued)

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
SD2_RX[3:0]	Receive Data (negative)	AK31, AJ29, AF29, AE31	I	XV_{DD_SRDS2}	—
SD2_TX[3]	SGMII Tx Data eTSEC4	AH26	O	XV_{DD_SRDS2}	—
SD2_TX[2]	SGMII Tx Data eTSEC3	AG24	O	XV_{DD_SRDS2}	—
SD2_TX[1]	SGMII Tx Data eTSEC2	AE24	O	XV_{DD_SRDS2}	—
SD2_TX[0]	SGMII Tx Data eTSEC1	AD26	O	XV_{DD_SRDS2}	—
SD2_TX[3:0]	Transmit Data (negative)	AH27, AG25, AE25, AD27	O	XV_{DD_SRDS2}	—
SD2_PLL_TPD	PLL Test Point Digital	AH32	O	XV_{DD_SRDS2}	17
SD2_REF_CLK	PLL Reference Clock	AG32	I	XV_{DD_SRDS2}	—
SD2_REF_CLK	PLL Reference Clock Complement	AG31	I	XV_{DD_SRDS2}	—
Reserved	—	AF26, AF27	—	—	28
General-Purpose Input/Output					
GPINOUT[0:7]	General Purpose Input / Output	B27, A28, B31, A32, B30, A31, B28, B29	I/O	BV_{DD}	—
System Control					
HRESET	Hard Reset	AC31	I	OV_{DD}	—
HRESET_REQ	Hard Reset Request	L23	O	OV_{DD}	21
SRESET	Soft Reset	P24	I	OV_{DD}	—
CKSTP_IN0	Checkstop In Processor 0	N26	I	OV_{DD}	—
CKSTP_IN1	Checkstop In Processor 1	N25	I	OV_{DD}	—
CKSTP_OUT0	Checkstop Out Processor 0	U29	O	OV_{DD}	2, 4
CKSTP_OUT1	Checkstop Out Processor 1	T25	O	OV_{DD}	2, 4
Debug					
TRIG_IN	Trigger In	P26	I	OV_{DD}	—
TRIG_OUT/READY_P0/QUIESCE	Trigger Out / Ready Processor 0/ Quiesce	P25	O	OV_{DD}	21
READY_P1	Ready Processor 1	N28	O	OV_{DD}	5, 9

Table 76. MPC8572E Pinout Listing (continued)

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
SD1_IMP_CAL_RX	SerDes1 Rx Impedance Calibration	B32	I	200Ω (±1%) to GND	—
SD1_IMP_CAL_TX	SerDes1 Tx Impedance Calibration	T32	I	100Ω (±1%) to GND	—
SD1_PLL_TPA	SerDes1 PLL Test Point Analog	J30	O	AVDD_SRDS analog	17
SD2_IMP_CAL_RX	SerDes2 Rx Impedance Calibration	AC32	I	200Ω (±1%) to GND	—
SD2_IMP_CAL_TX	SerDes2 Tx Impedance Calibration	AM32	I	100Ω (±1%) to GND	—
SD2_PLL_TPA	SerDes2 PLL Test Point Analog	AH30	O	AVDD_SRDS analog	17
TEMP_ANODE	Temperature Diode Anode	AA31	—	internal diode	14
TEMP_CATHODE	Temperature Diode Cathode	AB31	—	internal diode	14
No Connection Pins					

in the above equation refers to the negotiated link width as the result of PCI Express link training, which may or may not be the same as the link width POR selection.

For proper serial RapidIO operation, the CCB clock frequency must be greater than:

$$\frac{2 \times (0.80) \times (\text{serial RapidIO interface frequency}) \times (\text{serial RapidIO link width})}{64}$$

See Section 20.4, "1x/4x LP-Serial Signal Descriptions," in the *MPC8572E PowerQUICC III Integrated Host Processor Family Reference Manual* for Serial RapidIO interface width and frequency details.

20 Thermal

This section describes the thermal specifications of the MPC8572E.

Table 84 shows the thermal characteristics for the package, 1023 33 × 33 FC-PBGA.

The package uses a 29.6 × 29.6 mm lid that attaches to the substrate. Recommended maximum heat sink force is 10 pounds force (45 Newton).

Table 84. Package Thermal Characteristics

Rating	Board	Symbol	Value	Unit	Notes
Junction to ambient, natural convection	Single-layer (1s)	$R_{\Theta JA}$	15	°C/W	1, 2
Junction to ambient, natural convection	Four-layer (2s2p)	$R_{\Theta JA}$	11	°C/W	1, 3
Junction to ambient (at 200 ft./min.)	Single-layer (1s)	$R_{\Theta JMA}$	11	°C/W	1, 3
Junction to ambient (ar 200 ft./min.)	Four-layer (2s2p)	$R_{\Theta JMA}$	8	°C/W	1, 3
Junction to board	—	$R_{\Theta JB}$	4	°C/W	4
Junction to case	—	$R_{\Theta JC}$	0.5	°C/W	5

Notes:
1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance
2. Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.
3. Per JEDEC JESD51-6 with the board (JESD51-7) horizontal.
4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
5. Thermal resistance between the active surface of the die and the case top surface determined by the cold plate method (MIL SPEC-883, Method 1012.1).

20.1 Temperature Diode

The MPC8572E has a temperature diode on the microprocessor that can be used in conjunction with other system temperature monitoring devices (such as Analog Devices, ADT7461™). These devices use the negative temperature coefficient of a diode operated at a constant current to determine the temperature of the microprocessor and its environment. It is recommended that each MPC8572E device be calibrated.

The following are the specifications of the on-board temperature diode:

21.6 Pull-Up and Pull-Down Resistor Requirements

The MPC8572E requires weak pull-up resistors (2–10 kΩ is recommended) on open drain type pins including I^2C pins and MPIC interrupt pins.

Correct operation of the JTAG interface requires configuration of a group of system control pins as demonstrated in Figure 66. Care must be taken to ensure that these pins are maintained at a valid deasserted state under normal operating conditions as most have asynchronous behavior and spurious assertion gives unpredictable results.

The following pins must NOT be pulled down during power-on reset: $\overline{\text{DMA\_DACK}}$[0:1], EC5_MDC, $\overline{\text{HRESET\_REQ}}$, TRIG_OUT/READY_P0/$\overline{\text{QUIESCE}}$, MSRCID[2:4], MDVAL, and ASLEEP. The $\overline{\text{TEST\_SEL}}$ pin must be set to a proper state during POR configuration. For more details, refer to the pinlist table of the individual device.

21.7 Output Buffer DC Impedance

The MPC8572E drivers are characterized over process, voltage, and temperature. For all buses, the driver is a push-pull single-ended driver type (open drain for I^2C).

To measure Z_0 for the single-ended drivers, an external resistor is connected from the chip pad to OV_{DD} or GND. Then, the value of each resistor is varied until the pad voltage is $OV_{DD}/2$ (see Figure 64). The output impedance is the average of two components, the resistances of the pull-up and pull-down devices. When data is held high, SW1 is closed (SW2 is open) and R_P is trimmed until the voltage at the pad equals $OV_{DD}/2$. R_P then becomes the resistance of the pull-up devices. R_P and R_N are designed to be close to each other in value. Then, $Z_0 = (R_P + R_N)/2$.

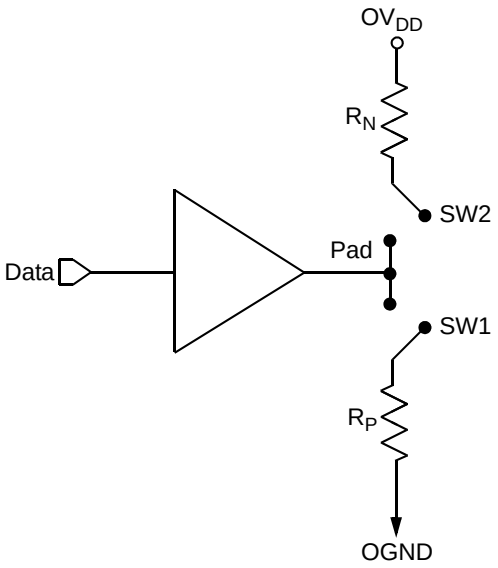


Figure 64. Driver Impedance Measurement

logic does not interfere with normal chip operation. While the TAP controller can be forced to the reset state using only the TCK and TMS signals, generally systems assert $\overline{\text{TRST}}$ during the power-on reset flow. Simply tying $\overline{\text{TRST}}$ to $\overline{\text{HRESET}}$ is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP), which implements the debug interface to the chip.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert $\overline{\text{HRESET}}$ or $\overline{\text{TRST}}$ to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in Figure 66 allows the COP port to independently assert $\overline{\text{HRESET}}$ or $\overline{\text{TRST}}$, while ensuring that the target can drive $\overline{\text{HRESET}}$ as well.

The COP interface has a standard header, shown in Figure 65, for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; so emulator vendors have issued many different pin numbering schemes. Some COP headers are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom. Still others number the pins counter-clockwise from pin 1 (as with an IC). Regardless of the numbering scheme, the signal placement recommended in Figure 65 is common to all known emulators.

21.9.1 Termination of Unused Signals

If the JTAG interface and COP header is not used, Freescale recommends the following connections:

- $\overline{\text{TRST}}$ should be tied to $\overline{\text{HRESET}}$ through a 0 kΩ isolation resistor so that it is asserted when the system reset signal ($\overline{\text{HRESET}}$) is asserted, ensuring that the JTAG scan chain is initialized during the power-on reset flow. Freescale recommends that the COP header be designed into the system as shown in Figure 66. If this is not possible, the isolation resistor allows future access to $\overline{\text{TRST}}$ in case a JTAG interface may need to be wired onto the system in future debug situations.
- No pull-up/pull-down is required for TDI, TMS, TDO or TCK.

21.10.3 SerDes 2 Interface (SGMII) Entirely Unused

If the high-speed SerDes 2 interface (SGMII) is not used at all, the unused pin should be terminated as described in this section.

The following pins must be left unconnected (float):

- SD2_TX[3:0]
- $\overline{\text{SD2\_TX}}$[3:0]
- Reserved pins: AF26, AF27

The following pins must be connected to XGND_SRDS2:

- SD2_RX[3:0]
- $\overline{\text{SD2\_RX}}$[3:0]
- SD2_REF_CLK
- $\overline{\text{SD2\_REF\_CLK}}$

The POR configuration pin cfg_srds_sgmii_en on $\overline{\text{UART\_RTS}}$[1] can be used to power down SerDes 2 block for power saving. Note that both SVDD_SRDS2 and XVDD_SRDS2 must remain powered.

21.10.4 SerDes 2 Interface (SGMII) Partly Unused

If only part of the high speed SerDes 2 interface (SGMII) pins are used, the remaining high-speed serial I/O pins should be terminated as described in this section.

The following pins must be left unconnected (float):

- SD2_TX[3:0]
- $\overline{\text{SD2\_TX}}$[3:0]
- Reserved pins: AF26, AF27

The following pins must be connected to XGND_SRDS2:

- SD2_RX[3:0]
- $\overline{\text{SD2\_RX}}$[3:0]

[3] Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by part number specifications may support other maximum core frequencies.

22.2 Part Marking

Parts are marked as the example shown in Figure 67.

FC-PBGA

Notes:
MMMMMM is the 6-digit mask number.
ATWLYYWW is the traceability code.
CCCCC is the country of assembly. This space is left blank if parts are assembled in the United States.

Figure 67. Part Marking for FC-PBGA Device

Table 89 explains line four of Figure 67.

Table 89. Meaning of Last Line of Part Marking

Digit	Description
A	Assembly Site E Oak Hill Q KLM
WL	Lot number
YY	Year assembled
WW	Work week assembled

23 Document Revision History

Table 90 provides a revision history for the MPC8572E hardware specification.

Table 90. Document Revision History

Rev. Number	Date	Substantive Change(s)
7	03/2016	• Updated Section 22.2, “Part Marking,” changed the five-digit mask number to six digits.